

SN54HC241 SN74HC241 OCTAL BUFFERS AND LINE DRIVERS WITH 3-STATE OUTPUTS

SCLS300A – JANUARY 1996 – REVISED MAY 1997

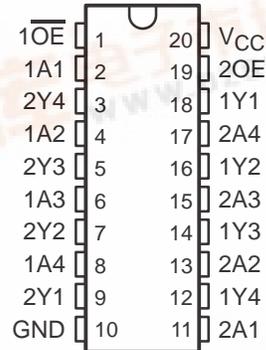
- 3-State Outputs Drive Bus Lines or Buffer Memory Address Registers
- High-Current Outputs Drive up to 15 LSTTL Loads
- Package Options Include Plastic Small-Outline (DW) and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

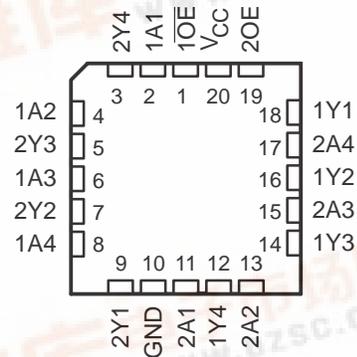
These octal buffers and line drivers are designed specifically to improve both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters. The 'HC241 are organized as two 4-bit buffers/drivers with separate output-enable ($\overline{1OE}$ and 2OE) inputs. When $\overline{1OE}$ is low or 2OE is high, the device passes noninverted data from the A inputs to the Y outputs. When $\overline{1OE}$ is high or 2OE is low, the outputs for the respective buffers/drivers are in the high-impedance state.

The SN54HC241 is characterized for operation over the full military temperature range of -55°C to 125°C . The SN74HC241 is characterized for operation from -40°C to 85°C .

SN54HC241 . . . J OR W PACKAGE
SN74HC241 . . . DW OR N PACKAGE
(TOP VIEW)



SN54HC241 . . . FK PACKAGE
(TOP VIEW)



FUNCTION TABLES

INPUTS		OUTPUT
$\overline{1OE}$	1A	1Y
L	H	H
L	L	L
H	X	Z

INPUTS		OUTPUT
2OE	2A	2Y
H	H	H
H	L	L
L	X	Z

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recommended operating conditions

		SN54HC241			SN74HC241			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage	2	5	6	2	5	6	V
V _{IH}	High-level input voltage	V _{CC} = 2 V		1.5	1.5		V	
		V _{CC} = 4.5 V		3.15	3.15			
		V _{CC} = 6 V		4.2	4.2			
V _{IL}	Low-level input voltage	V _{CC} = 2 V		0	0.5	0	0.5	V
		V _{CC} = 4.5 V		0	1.35	0	1.35	
		V _{CC} = 6 V		0	1.8	0	1.8	
V _I	Input voltage	0	V _{CC}		0	V _{CC}		V
V _O	Output voltage	0	V _{CC}		0	V _{CC}		V
t _t	Input transition (rise and fall) time	V _{CC} = 2 V		0	1000	0	1000	ns
		V _{CC} = 4.5 V		0	500	0	500	
		V _{CC} = 6 V		0	400	0	400	
T _A	Operating free-air temperature	-55		125	-40		85	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{CC}	T _A = 25°C			SN54HC241		SN74HC241		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V _{OH}	V _I = V _{IH} or V _{IL}	I _{OH} = -20 μA	2 V	1.9	1.998	1.9	1.9	V		
			4.5 V	4.4	4.499	4.4	4.4			
			6 V	5.9	5.999	5.9	5.9			
		I _{OH} = -6 mA	4.5 V	3.98	4.3	3.7	3.84			
		I _{OH} = -7.8 mA	6 V	5.48	5.8	5.2	5.34			
V _{OL}	V _I = V _{IH} or V _{IL}	I _{OL} = 20 μA	2 V	0.002	0.1	0.1	0.1	V		
			4.5 V	0.001	0.1	0.1	0.1			
			6 V	0.001	0.1	0.1	0.1			
		I _{OL} = 6 mA	4.5 V	0.17	0.26	0.4	0.33			
		I _{OL} = 7.8 mA	6 V	0.15	0.26	0.4	0.33			
I _I	V _I = V _{CC} or 0	6 V	±0.1	±100	±1000	±1000	nA			
I _{OZ}	V _O = V _{CC} or 0	6 V	±0.01	±0.5	±10	±5	μA			
I _{CC}	V _I = V _{CC} or 0, I _O = 0	6 V		8	160	80	μA			
C _i		2 V to 6 V	3	10	10	10	pF			

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switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$
(unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC}	$T_A = 25^\circ\text{C}$			SN54HC241		SN74HC241		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{pd}	A	Y	2 V		39	115		170		145	ns
			4.5 V		12	23		34		29	
			6 V		11	20		29		25	
t_{en}	\overline{OE} or OE	Y	2 V		60	150		225		190	ns
			4.5 V		17	30		45		38	
			6 V		15	26		38		32	
t_{dis}	\overline{OE} or OE	Y	2 V		40	150		225		190	ns
			4.5 V		18	30		45		38	
			6 V		17	26		38		32	
t_t		Y	2 V		28	60		90		75	ns
			4.5 V		8	12		18		15	
			6 V		6	10		15		13	

switching characteristics over recommended operating free-air temperature range, $C_L = 150 \text{ pF}$
(unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC}	$T_A = 25^\circ\text{C}$			SN54HC241		SN74HC241		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{pd}	A	Y	2 V		50	165		245		210	ns
			4.5 V		16	33		49		42	
			6 V		14	28		42		35	
t_{en}	\overline{OE} or OE	Y	2 V		100	200		300		250	ns
			4.5 V		20	40		60		50	
			6 V		17	34		51		43	
t_t		Y	2 V		45	210		315		265	ns
			4.5 V		17	42		63		53	
			6 V		13	36		53		45	

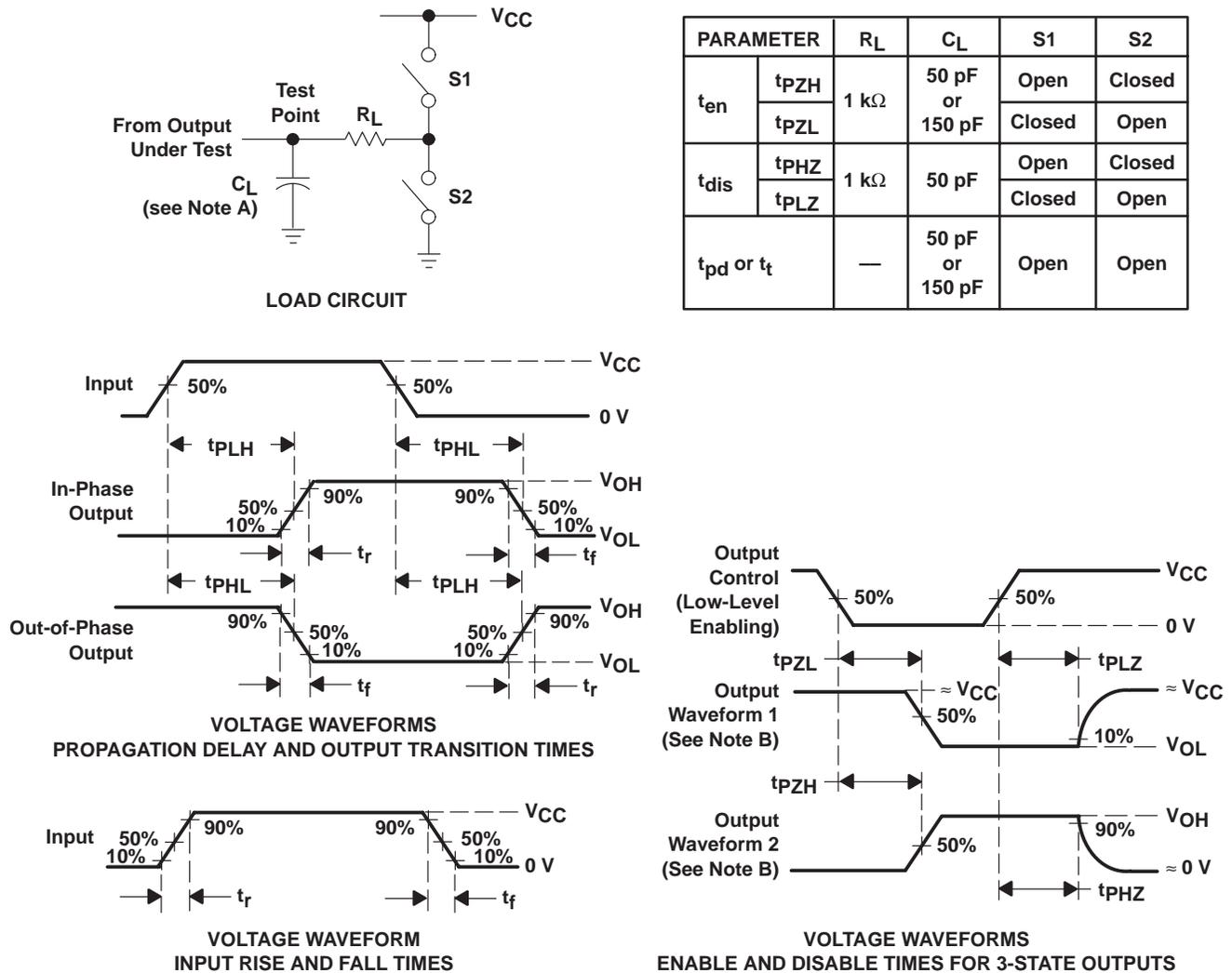
operating characteristics, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TYP	UNIT
C_{pd} Power dissipation capacitance per buffer/driver	No load	35	pF

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PARAMETER MEASUREMENT INFORMATION



- NOTES:
- A. C_L includes probe and test-fixture capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \Omega$, $t_r = 6$ ns, $t_f = 6$ ns.
 - D. The outputs are measured one at a time with one input transition per measurement.
 - E. t_{PLZ} and t_{PHZ} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 1. Load Circuit and Voltage Waveforms

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